

Data Sheet

Customer:

Product: SMD Aluminum Electrolytic Capacitors – AEMV Series

Size : 4x5.5mm ~ 18x16.5mm

Issued Date: 15-May.-2016

Edition: Ver. 1

Record of change

Date	Ver.	Description	Page
20-Dec-2023	1		

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20-Dec-2023	20-Dec-2023	20-Dec-2023	
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- SMD TYPE Reflow Soldering is available
- Life 5000 hours at 105°C
- Available For High Density Mounting
- AEC-Q200 version available

Characteristics

Voltage Range	6.3 ~ 100V								
Temperature Range	-40°C ~ +105°C								
Capacitance Tolerance	$\pm 20\%$ (at 20°C, 120Hz)								
Leakage Current	$I \leq 0.01CV$ or 3uA, whichever is greater 2 minutes after Rated Voltage applied								
Dissipation Factor (tanδ)Max (at 20°C, 120Hz)	Rated Voltage (V)	6.3	10	16	25	35	50	63	100
	D.F. (tanδ)	0.32	0.28	0.22	0.16	0.13	0.12	0.089	0.07
Stability at Low Temperature (at 120Hz)	Rated Voltage (V)	6.3	10	16	25	35	50	63	100
	Z-25°C/Z 20°C	4	3	2	2	2	2	2	2
	Z-40°C/Z 20°C	10	7	5	3	3	3	3	3
Load Life	After the rated voltage has been applied for 5000 hours at 105°C	Capacitance change			Within $\pm 30\%$ of initial value				
		D.F. tanδ			Less than $\pm 300\%$ of specified value				
		Leakage current			Less than Initial specified value				
Shelf Life	After storage for 1000 hours at 105°C, with no voltage applied and being stabilized at +20°C, Capacitor shall meet the limit specified in load life.(Refer to JIS C5101-4 4.1)								

Diagram of dimensions

SIZE	D _Φ	L	A	B	C	W	P±0.2
A	4	5.5±0.3	4.3	4.3	5.1	0.5~0.8	1.0
B	5	5.5±0.3	5.3	5.3	5.9	0.5~0.8	1.5
C	6.3	5.5±0.3	6.6	6.6	7.2	0.5~0.8	2.0
C8	6.3	7.7±0.3	6.6	6.6	7.2	0.5~0.8	2.0
D	8	6.5±0.3	8.4	8.4	9.0	0.5~0.8	2.3
E	8	10.5±0.3	8.4	8.4	9.0	0.7~1.1	3.1
F	10	10.5±0.3	10.4	10.4	11.0	0.7~1.3	4.5
G	12.5	14±0.5	13.5	13.5	15.0	1.1~1.4	4.5
H	12.5	16±0.5	13.0	13.0	15.0	1.1~1.4	4.5
I	16	16.5±0.5	17.0	17.0	18.0	1.1~1.4	6.4
J	16	21.5±0.5	17.0	17.0	18.0	1.1~1.4	6.4
K	18	16.5±0.5	19.0	19.0	20.0	1.1~1.4	6.4

Size A~F refer to Fig. 1,

Size G~K refer to Fig. 2

Fig. 1

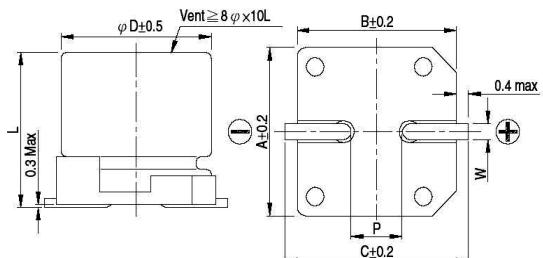
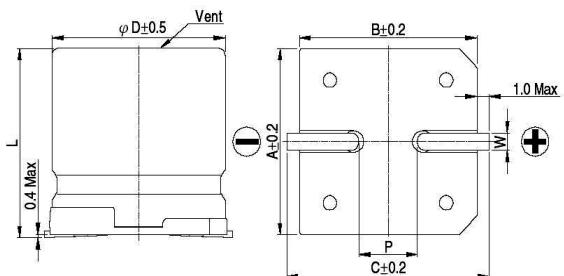


Fig. 2



Multiplier for Ripple Current vs Frequency

CAP(uF)\Freq(Hz)	60(50)	120	500	1K	≥10K
0.1≤CAP≤100	0.8	1.0	1.20	1.30	1.50
100<CAP	0.8	1.0	1.10	1.15	1.20

Case size & Maximum Ripple Current (mA rms 105°C 120Hz)

WV Cap.	6.3		10		16		25	
uF	Size	RC	Size	RC	Size	RC	Size	RC
1								
2.2								
3.3								
4.7							A	13
10					A	17	A	23
22	A	22	B	28	B	30	C	40
33	B	32	B	34	C	44	C	48
47	B	36	C	48	C	50	C8	63
100	C	60	C8	79	C8	81	E	116
220	C8	110	E	140	F	216	F	240
330	E	160	F	240	F	300	F	375
470	F	260	F	280	F	320		
1000	F	340						

WV Cap.	35		50		63		100	
uF	Size	RC	Size	RC	Size	RC	Size	RC
1			A	6.2				
2.2			A	11				
3.3			A	14				
4.7	A	15	B	19				
10	B	25	C	30				
22	C	42	C8	52				
33	C8	57	E	80				
47	E	92	E	95				
100	F	150	F	160			H	240
220	F	280	G	280	G	320	I	340
330	G	320	H	360	H	450	I	410
470	H	410	I	510	I	540	K	540
1000	I	690	K	780				

Part Numbering System

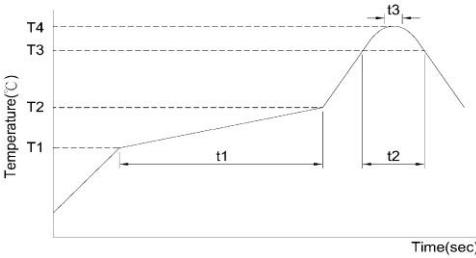
AEMV R
 Series Capacitance Tolerance Rated Voltage Package Case Size

Reliability for Car- Tronics

AEC Q-200_REV D

Endurance Characteristic:

No.	Item	Conditions	Specification		Reference														
1	High Temperature Load Life Test	Capacitor is placed in the highest temperature with rated voltage for 5000+72/-0Hrs.	Capacitance change	Within ±30% of initial value	MIL-STD-202 Method 108														
			Tanδ	Less than 300% of specified value															
			Leakage Current	Within specified value															
			Appearance	No abnormality															
2	High Temperature Exposure (Storage)	Capacitor is placed in the highest temperature for 1000+48/-0Hrs.	Capacitance change	Within ±30% of initial value	MIL-STD-202 Method 108														
			Tanδ	Less than 300% of specified value															
			Leakage Current	Within specified value															
			Appearance	No abnormality															
3	Temperature Cycling	Step1: Max. rated temperature±3/-3°C(30±3mins) Step2: Min. rated temperature±3/-3°C(30±3mins) Max.transfer time: 1min According to the step1 to step2, and do 1000cycles	Capacitance change	Within ±10% of initial value	JESD22 Method JA-104														
			Tan δ	Within specified value															
			Leakage Current	Within specified value															
			Appearance	No abnormality															
4	Biased Humidity	Capacitor is placed at the temperature of 85±3°C, and humidity of 85% with rated voltage for 1000Hrs	Capacitance change	Within ±20% of initial value	MIL-STD-202 Method 103														
			Tanδ	Less than 150% of specified value															
			Leakage Current	Within specified value															
			Appearance	No abnormality															
5	Physical Dimension		Appearance	No abnormality	JESD22 Method JB-100														
6	Resistance To Solvent	1.The capacitor shall be immersed into the isopropyl. 2.Immersion time: 3 +0.5/-0 minutes at 25±5°C. 3.Use wool brush to brush capacitor for 10 times. Conduct the steps 1~3 for 3 cycles.	Print cannot fall off or ambiguous		MIL-STD-202 Method 215														
7	Mechanical Shock	Capacitor is placed on the PCB and fixed. Conditions as below: <table border="1"> <tr><td>Test items</td><td>For automobile</td></tr> <tr><td>Acceleration speed</td><td>100g(1000 m/s²)</td></tr> <tr><td>Shocking direction</td><td>X-Y-Z three axles (6 planes)</td></tr> <tr><td>Duration(D)(ms)</td><td>6</td></tr> <tr><td>Velocity(m/s)</td><td>3.75</td></tr> <tr><td>Wave</td><td>Half sine</td></tr> <tr><td>Test times</td><td>18times (3*6=18)</td></tr> </table>	Test items	For automobile	Acceleration speed	100g(1000 m/s ²)	Shocking direction	X-Y-Z three axles (6 planes)	Duration(D)(ms)	6	Velocity(m/s)	3.75	Wave	Half sine	Test times	18times (3*6=18)	Capacitance change	Within ±10% of initial value	MIL-STD-202 Method 213
Test items	For automobile																		
Acceleration speed	100g(1000 m/s ²)																		
Shocking direction	X-Y-Z three axles (6 planes)																		
Duration(D)(ms)	6																		
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Test times	18times (3*6=18)																		
		Tanδ	Within specified value																
		Leakage Current	Within specified value																
		Appearance	No abnormality																
8	Vibration	Capacitor is placed in the PCB and fixed. Setting the acceleration (5g)and frequency (10-2000Hz) according to the test condition ,vibration 4Hrs from three directions (X-Y-Z).	Capacitance change	Within ±10% of initial value	MIL-STD-202 Method 204														
			Tan δ	Within specified value															
			Leakage Current	Within specified value															
			Appearance	No abnormality															

No.	Item	Conditions	Specification		Reference																																							
9	Resistance to Soldering Heat	According to the Control standard operating of Jarson, test twice. 	Capacitance change	Within ±10% of initial value	MIL-STD-202 Method 210																																							
		Tanδ	Within specified value																																									
		Leakage Current	Within specified value																																									
		Appearance	No abnormality																																									
		<table border="1"> <tr><td>Rated voltage (V)</td><td>4~50</td><td>63 up</td><td>4~100</td></tr> <tr><td>Case size (φ)</td><td>4~6.3</td><td>4~6.3</td><td>8~12.5</td></tr> <tr><td>Preheat</td><td>Temp.(T1~T2,°C)</td><td colspan="3">150~180</td></tr> <tr><td></td><td>Time (t1)(Max,secs)</td><td colspan="3">100</td></tr> <tr><td>Duration</td><td>Temp.(T3,°C)</td><td>217</td><td>230</td><td>217</td></tr> <tr><td></td><td>Time (t2)(Max,secs)</td><td>90</td><td>60</td><td>60</td></tr> <tr><td>Peak</td><td>Temp.(T4,°C)</td><td colspan="3">250</td></tr> <tr><td></td><td>Time (t3,secs)</td><td colspan="3">5</td></tr> <tr><td colspan="2" rowspan="5">Reflow cycles</td><td colspan="3" rowspan="5">2 or less</td></tr> </table>		Rated voltage (V)	4~50	63 up	4~100	Case size (φ)	4~6.3	4~6.3	8~12.5	Preheat	Temp.(T1~T2,°C)	150~180				Time (t1)(Max,secs)	100			Duration	Temp.(T3,°C)	217	230	217		Time (t2)(Max,secs)	90	60	60	Peak	Temp.(T4,°C)	250				Time (t3,secs)	5			Reflow cycles		2 or less
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Peak	Temp.(T4,°C)	250																																										
	Time (t3,secs)	5																																										
Reflow cycles		2 or less																																										
10	Solderability test (SMD)	Solderability test 1: Solder bath temperature: 235±5°C Duration:5±0/-0.5s Solderability test 2:Solder bath temperature:260±5°C Duration:7±0.5s	Sn is more than 95% in the surface of terminal		J-STD-002B																																							
11	Electrical Characterization	Whether there is abnormality about electrical characterization in the test that under the ensurance temperature(the lowest ,the highest, atmospheric temperature).	Appearance: No abnormality		User Spec.																																							
12	Board Flex	Capacitor is placed in the PCB and pressed to deviate from Original fulcrum more than 2mm for 60 (+5) s.	Capacitance change	Within ±10% of initial value	AEC-Q200-005																																							
			Tanδ	Within specified value																																								
			Leakage Current	Within specified value																																								
			Appearance	No abnormality																																								
13	Terminal Strength (SMD)	Test condition: Capacitor is placed in the PCB by solder paste and do high temperature test (Reflow) to endurance the power of 1.8kg for 60S,no dropping condition.	Capacitance change	Within ±10% of initial value	AEC-Q200-006																																							
			Tanδ	Within specified value																																								
			Leakage Current	Within specified value																																								
			Appearance	No abnormality																																								
14	Surge Voltage	Capacitor is placed at 15°C~35°C with surge voltage for 30±5(charging) and 330s(discharging),do surge voltage test continuity for 1000 times. Applying voltage: <table border="1"><tr><td>W.V.</td><td>6.3</td><td>10</td><td>16</td><td>25</td><td>35</td><td>50</td><td>63</td></tr><tr><td>S. V.</td><td>7.3</td><td>11.5</td><td>18.4</td><td>28.8</td><td>40.3</td><td>57.5</td><td>72.5</td></tr><tr><td>W.V.</td><td>80</td><td>100</td><td>160</td><td>200</td><td>250</td><td>400</td><td>450</td></tr><tr><td>S. V.</td><td>92</td><td>115</td><td>184</td><td>230</td><td>288</td><td>440</td><td>495</td></tr></table>	W.V.	6.3	10	16	25	35	50	63	S. V.	7.3	11.5	18.4	28.8	40.3	57.5	72.5	W.V.	80	100	160	200	250	400	450	S. V.	92	115	184	230	288	440	495	Capacitance change	Within ±20% of initial value	AEC-Q200-007							
W.V.	6.3	10	16	25	35	50	63																																					
S. V.	7.3	11.5	18.4	28.8	40.3	57.5	72.5																																					
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